

<b>Notice of References Cited</b>	Application/Control No. 10/766,103		Applicant(s)/Patent Under Reexamination NG ET AL.	
	Examiner TOD T. VAN ROY		Art Unit 2828	Page 1 of 1

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*	B	US-6,816,516	11-2004	Daiber, Andrew	372/20
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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